

Si/SiC Hybrid Modules -

EliteSiC, 3 Channel Flying Capacitor Boost 1000 V, 100 A IGBT, 1200 V, 30 A SiC Diode, Q2 Package

NXH300B100H4Q2F2, NXH300B100H4Q2F2SG-R

This high-density, integrated power module combines high-performance IGBTs with 1200 V SiC diode.

Features

- Extremely Efficient Trench with Field Stop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- 3-channel in Q2BOOST Package
- These are Pb-Free Devices

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies

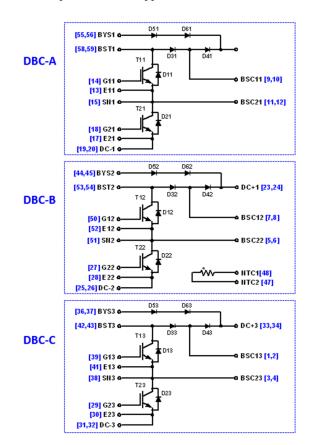
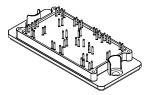


Figure 1. NXH300B100H4Q2F2PG/SG/SG-R Schematic Diagram

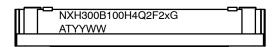


PIM53, 93x47 (PRESSFIT) CASE 180CB



PIM53, 93x47 (SOLDER PIN) CASE 180CC

MARKING DIAGRAM

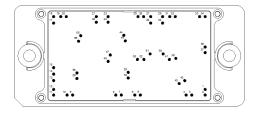


NXH300B100H4Q2F2x = Specific Device Code

(x = P, S)

AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

PIN CONNECTION



ORDERING INFORMATION

See detailed ordering and shipping information on page 11 of this data sheet.

ABSOLUTE MAXIMUM RATINGS (Note 1) (T,I = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
IGBT (T11	, T21, T12, T22, T13, T23)		
V _{CES}	Collector-Emitter voltage	1000	V
V_{GE}	Gate-Emitter Voltage Positive transient gate-emitter voltage (Tpulse = 5 μ s, D < 0.10)	±20 30	V
I _C	Continuous Collector Current (@ V _{GE} = 20 V, T _C = 80°C)	73	А
I _{C(Pulse)}	Pulsed Peak Collector Current @ T _C = 80°C (T _J = 150°C)	219	А
P _{tot}	Power Dissipation (T _J = 150°C, T _C = 80°C)	194	W
T _{JMIN}	Minimum Operating Junction Temperature	-40	°C
T_{JMAX}	Maximum Operating Junction Temperature	175	°C
IGBT INVI	RSE DIODE (D11, D21, D12, D22, D13, D23) AND BYPASS DIODE (D51, D61, D52, D62	, D53, D63)	
V_{RRM}	Peak Repetitive Reverse Voltage	1600	٧
I _F	Continuous Forward Current @ T _C = 80°C	36	А
I _{FRM}	Repetitive Peak Forward Current ($T_J = 150^{\circ}C$, T_J limited by T_{Jmax})	108	А
P _{tot}	Maximum Power Dissipation @ T _C = 80°C (T _J = 150°C)	79	W
T_{JMIN}	Minimum Operating Junction Temperature	-40	°C
T_{JMAX}	Maximum Operating Junction Temperature	150	°C
BOOST S	LICON CARBIDE SCHOTTKY DIODE (D31, D41, D32, D42, D33, D43)	•	•
V_{RRM}	Peak Repetitive Reverse Voltage	1200	V
I _F	Continuous Forward Current @ T _C = 80°C	36	А
I _{FRM}	Repetitive Peak Forward Current ($T_J = 150^{\circ}C$, T_J limited by T_{Jmax})	108	Α
P _{tot}	Maximum Power Dissipation @ T _C = 80°C (T _J = 150°C)	104	W
T _{JMIN}	Minimum Operating Junction Temperature	-40	°C
T_{JMAX}	Maximum Operating Junction Temperature	175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL AND INSULATION PROPERTIES (Note 1) (T_J = 25°C unless otherwise noted)

	TEAND INSOLATION PROPERTIES (Note 1) (1) = 25 C utiless otherwise noted)	1	_
Symbol	Rating	Value	Unit
THERMA	PROPERTIES		
T _{VJOP}	Operating Temperature under Switching Condition	-40 to 150	°C
T _{stg}	Storage Temperature Range	-40 to 125	°C
INSULATI	ON PROPERTIES		
V _{is}	Isolation Test Voltage, t = 2 sec, 50 Hz (Note 3)	4000	V_{RMS}
	Creepage Distance	12.7	mm
CTI	Comparative Tracking Index	>600	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 2. Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.
- 3. 4000 VAC_{BMS} for 1 second duration is equivalent to 3333 VAC_{BMS} for 1 minute duration.

Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
GBT (T11, T	T21, T12, T22, T13, T23)					
V _{(BR)CES}	Collector-Emitter Breakdown Voltage	V _{GE} = 0 V, I _C =1 mA	1000	1118	_	V
V _{CE(SAT)}	Collector-Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 100 A, T _C = 25°C	-	1.80	2.25	V
		V _{GE} = 15 V, I _C = 100 A, T _C = 150°C	_	2.03	_	
V _{GE(TH)}	Gate-Emitter Threshold Voltage	V _{GE} = V _{CE} , I _C = 100 mA	4.1	5.08	5.9	٧
I _{CES}	Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1000 V	=	-	800	μΑ
I _{GES}	Gate Leakage Current	V _{GE} = ±20 V, V _{CE} = 0 V	=	=	±400	nA
r _g	Internal Gate Resistor		-	5	-	Ω
t _{d(on)}	Turn-On Delay Time	T _j = 25°C	=	95	=	ns
t _r	Rise Time	$V_{CE} = 600 \text{ V}, I_{C} = 50 \text{ A}$ $V_{GE} = -9 \text{ V}, +15 \text{ V}, R_{G} = 6 \Omega$	=	15.42	=	
t _{d(off)}	Turn-Off Delay Time		=	267	=	
t _f	Fall time		=	59	=	
E _{on}	Turn on switching loss	1	_	1030	_	μJ
E _{off}	Turn off switching loss	1	-	1200	_	1
t _{d(on)}	Turn-On Delay Time	T _j = 125°C	=	97	=	ns
t _r	Rise Time	$V_{CE} = 600 \text{ V}, I_{C} = 50 \text{ A}$ $V_{GE} = -9 \text{ V}, +15 \text{ V}, R_{G} = 6 \Omega$	=	18	=	
t _{d(off)}	Turn-Off Delay Time		_	314	_	
t _f	Fall time		_	93	_	
E _{on}	Turn on switching loss		-	1260	_	μJ
E _{off}	Turn off switching loss		_	2140	_	
C _{ies}	Input capacitance	V _{CE} =20 V, V _{GE} = 0 V, f = 1 MHz	_	6323	_	pF
C _{oes}	Output capacitance		_	241	_	
C _{res}	Reverse transfer capacitance		_	34	_	1
Qg	Gate Charge	$V_{CE} = 600 \text{ V}, V_{GE} = -15/+15 \text{ V}, I_{C} = 75 \text{ A}$	-	340	_	nC
R _{thJH}	Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	_	0.66	_	K/W
R _{thJC}	Thermal Resistance - chip-to-case	$\lambda = 2.9 \text{ W/mK}$	_	0.48	_	K/W
GBT INVER	ISE DIODE (D11, D21, D12, D22, D13, D23) AND BYPASS DIODE (D51, D61, D52, D62	, D53, D6	63)		•
V _F	Diode Forward Voltage	I _F = 30 A, T _J = 25°C	_	1.04	1.7	V
		I _F = 30 A, T _J = 150°C	_	0.94	_	
R _{thJH}	Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil $\pm 2\%$ λ = 2.9 W/mK	=	1.04	-	K/W
OOST SILI	CON CARBIDE SCHOTTKY DIODE (D31,	D41, D32, D42, D33, D43)				
I _R	Diode Reverse Leakage Current	V _R = 1200 V, T _J = 25°C	-	-	600	μΑ
V _F	Diode Forward Voltage	I _F = 30 A, T _J = 25°C	-	1.42	1.7	V
		I _F = 30 A, T _J = 150°C	-	1.85	-	1
t _{rr}	Reverse Recovery Time	T _J = 25°C	_	15	_	ns
Q _{rr}	Reverse Recovery Charge	$V_{DS} = 600 \text{ V, } I_{C} = 50 \text{ A}$ $V_{GE} = -9 \text{ V, } 15 \text{ V, } R_{G} = 1 \Omega$	_	128	_	nC
I _{RRM}	Peak Reverse Recovery Current		=	13	=	Α
di/dt	Peak Rate of Fall of Recovery Current	1	-	4200	_	A/μs
E _{rr}	Reverse Recovery Energy		_	16	_	μJ

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Min	Тур	Max	Unit	
BOOST SIL	ICON CARBIDE SCHOTTKY DIODE (D31,	D41, D32, D42, D33, D43)			•	•
t _{rr}	Reverse Recovery Time	T _J = 125°C	=	19	=	ns
Q_{rr}	Reverse Recovery Charge	V_{DS} = 600 V, I_{C} = 50 A V_{GE} = -9 V, 15 V, R_{G} = 1 Ω	=	175	=	nC
I _{RRM}	Peak Reverse Recovery Current]	=	17	=	Α
di/dt	Peak Rate of Fall of Recovery Current]	=	3153	=	A/μs
E _{rr}	Reverse Recovery Energy	1		18	=	μJ
R_{thJH}	Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil $\pm 2\%$ $\lambda = 2.9$ W/mK		0.85	=	K/W
R _{thJC}	Thermal Resistance - chip-to-case			0.73	=	K/W
THERMISTO	OR CHARACTERISTICS					
R ₂₅	Nominal resistance		-	22	_	kΩ
R ₁₀₀	Nominal resistance	T = 100°C	-	1486	-	Ω
ΔR/R	Deviation of R25		-5	-	5	%
P_{D}	Power dissipation		-	200	-	mW
	Power dissipation constant		_	2	-	mW/K
	B-value	B (25/50), tolerance ±3%	_	3950	-	K
	B-value	B (25/100), tolerance ±3%	-	3998	_	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

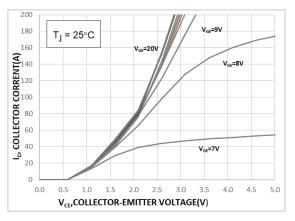


Figure 2. Typical Output Characteristics

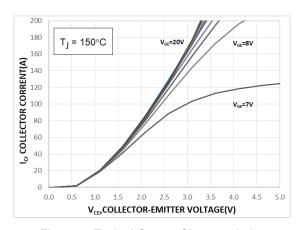


Figure 3. Typical Output Characteristics

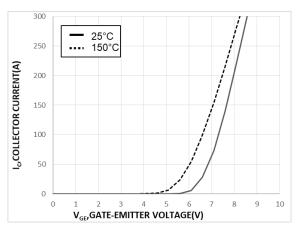


Figure 4. Transfer Characteristics

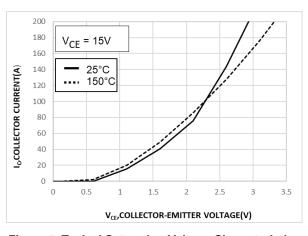


Figure 5. Typical Saturation Voltage Characteristics

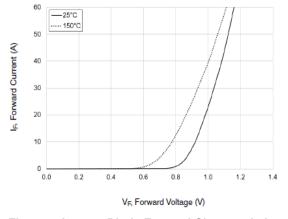


Figure 6. Inverse Diode Forward Characteristics

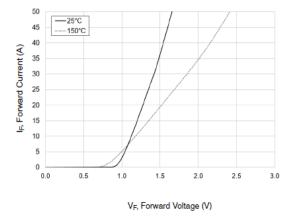


Figure 7. Boost Diode Forward Characteristics

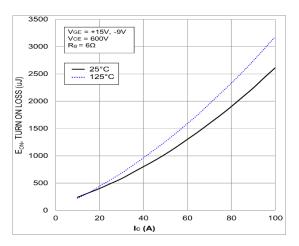


Figure 8. Typical Turn On Loss vs. I_C

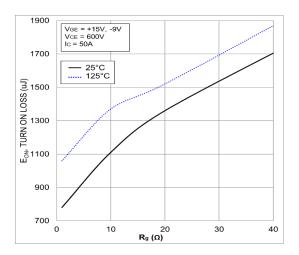


Figure 10. Typical Turn On Loss vs. R_g

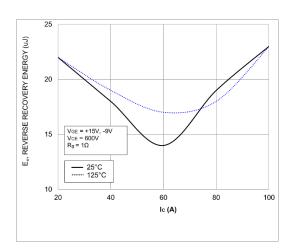


Figure 12. Typical Reverse Recovery Energy Loss vs. I_C

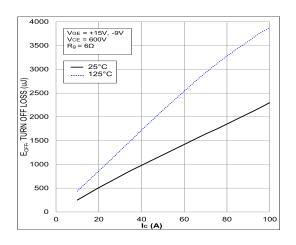


Figure 9. Typical Turn Off Loss vs. I_C

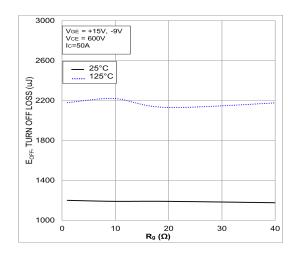


Figure 11. Typical Turn Off Loss vs. Rq

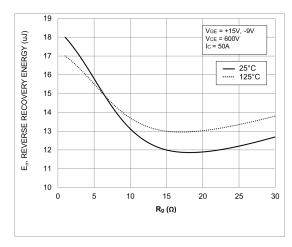


Figure 13. Typical Reverse Recovery Energy Loss vs. R_a

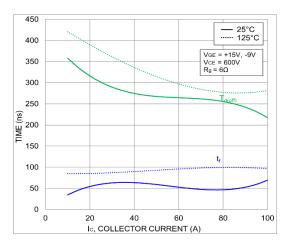


Figure 14. Typical Turn-Off Switching Time vs. I_C

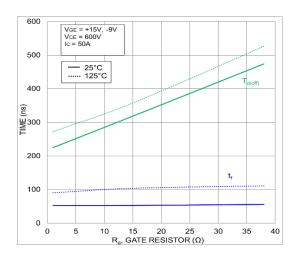


Figure 16. Typical Turn-Off Switching Time vs. Rg

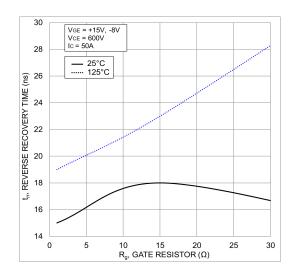


Figure 18. Typical Reverse Recovery Time vs. Rg

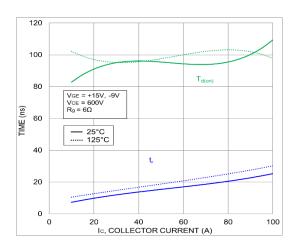


Figure 15. Typical Turn-On Switching Time vs. I_C

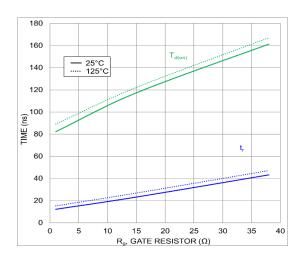


Figure 17. Typical Turn-On Switching Time vs. Rg

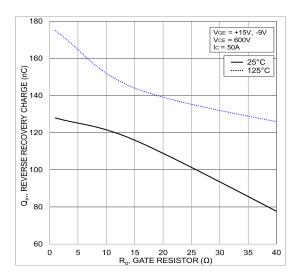


Figure 19. Typical Reverse Recovery Charge vs. Rg

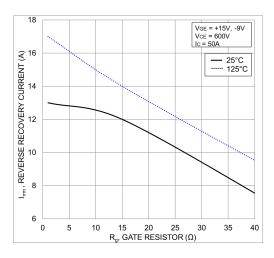


Figure 20. Typical Reverse Recovery Peak Current vs. R_g

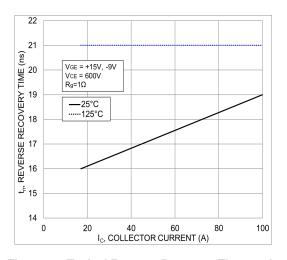


Figure 22. Typical Reverse Recovery Time vs. I_C

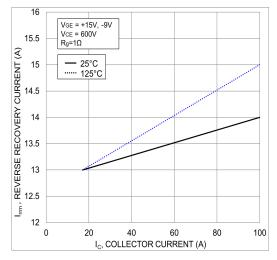


Figure 24. Typical Reverse Recovery Current vs. I_C

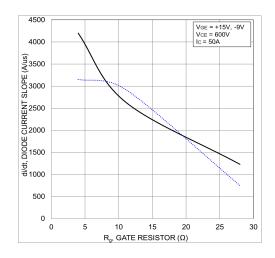


Figure 21. Typical di/dt vs. $R_{\mbox{\scriptsize g}}$

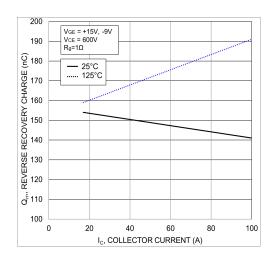


Figure 23. Typical Reverse Recovery Charge vs. I_C

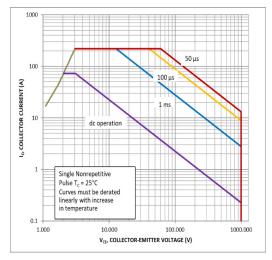


Figure 25. FBSOA

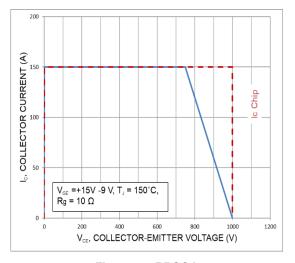


Figure 26. RBSOA

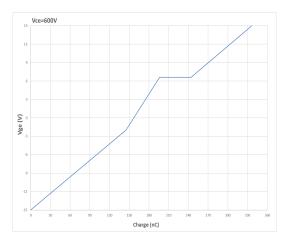


Figure 28. Gate Voltage vs. Gate Charge

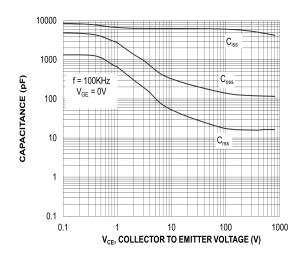


Figure 27. Capacitance Charge

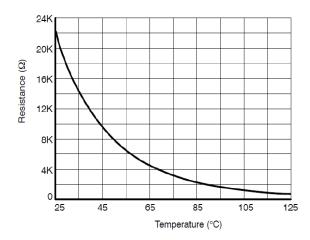


Figure 29. NTC Characteristics

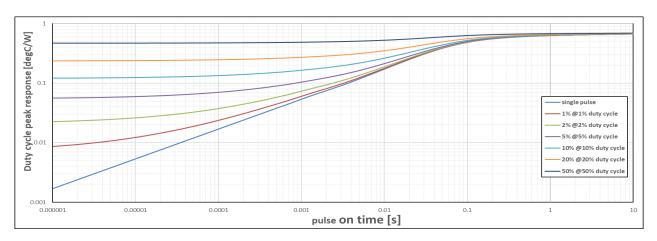


Figure 30. Transient Thermal Impedance (IGBT)

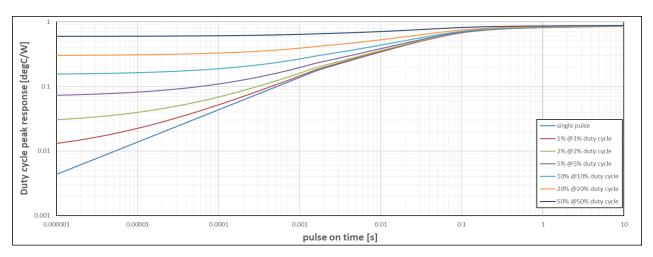


Figure 31. Transient Thermal Impedance (BOOST DIODE)

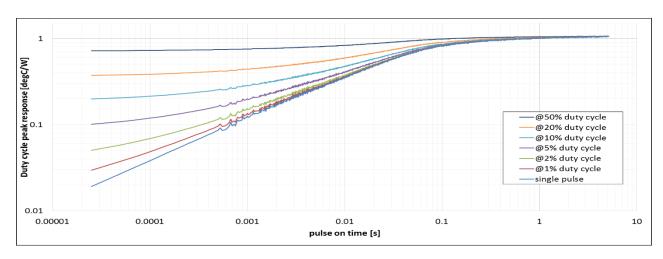
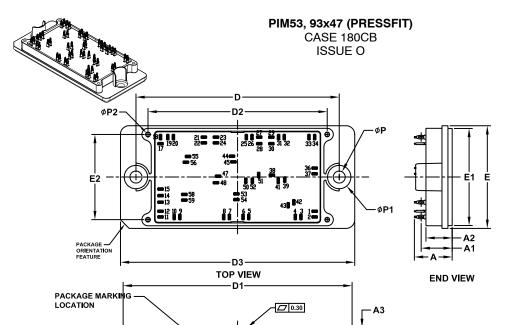


Figure 32. Transient Thermal Impedance (INVERSE&BYPASS DIODE)

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH300B100H4Q2F2PG PRESS FIT PINS	NXH300B100H4Q2F2PG	Q2BOOST - PIM53, 93x47 (PRESSFIT) (Pb-Free and Halide-Free Press Fit Pins)	12 Units / Blister Tray
NXH300B100H4Q2F2SG, NXH300B100H4Q2F2SG-R SOLDER PINS	NXH300B100H4Q2F2SG, NXH300B100H4Q2F2SG-R	Q2BOOST - PIM53, 93x47 (SOLDER PIN) (Pb-Free and Halide-Free Solder Pins)	12 Units / Blister Tray





DATE 30 APR 2020

	MILLIMETERS				
DIM	MIN.	NOM.	MAX.		
Α	16,90	17,30	17.70		
A1	13.97	14.18	14.39		
A2	11.70	12.00	12.30		
А3	4.40	4.70	5.00		
A4	16.40	16.70	17.00		
b	1.61	1.66	1.71		
b1	0.75	0.80	0.85		
D	92,90	93,00	93,10		
D1	104,45	104,75	105,05		
D2	81.80	82,00	82,20		
D3	106.90	107.20	107.50		
E	46.70	47.00	47.30		
E1	44.10	44.40	44.70		
E2	38.80	39.00	39.20		
Р	5.40	5.50	5.60		
P1	10,60	10,70	10,80		
P2	1,80	2.00	2,20		

NOTE 4

	PIN POSITION				PIN POSITION	
PIN	х	Y		PIN	х	Υ
1	70,50	2.60		29	50.70	36,50
2	70,50	0.00		30	50.70	33,50
3	64.25	0.00		31	54.00	36.50
4	61.65	0.00		32	56.60	36.50
5	40.35	0.00		33	67.90	36.50
6	37.75	0.00		34	70.50	36.50
7	31,50	0.00		36	70,50	22,35
8	28,90	0,00		37	70,50	19,75
9	8.85	0.00		38	50.95	19,15
10	6,25	0.00	l	39	56.85	17.05
11	0.00	0.00		41	53.85	16.55
12	0.00	2.60	l	42	61.00	6.70
13	0.00	6.75		43	58.40	5.35
14	0.00	9.75		44	32.65	27.80
15	0.00	12.75		45	33.35	25.20
17	0,00	33,50		47	26,35	18,65
18	0,00	36,50		48	25,35	15,65
19	3.30	36.50	l	50	39.00	16.55
20	5.90	36.50	l	51	44.90	19.15
21	19.80	36.50		52	42.00	16.55
22	19.80	33.90		53	34.70	10.55
23	25.35	36.50		54	34.70	7.95
24	25.35	33.90		55	12.60	27.65
25	39,25	36,50		56	11,60	25,05
26	41.85	36.50		58	10.85	10.30
27	45.15	36.50		59	10.85	7.70
28	45.15	33.50		_		_

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39.00	0 55 440 38 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3	698
0.00 \$\frac{1}{\phi_{2.50}}\$		01.41~1.56
NOTES	RECOMMENDED MOUNTING PATTERN	PLATED THRU HOLE

SIDE VIEW 93.00 82.00

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
- 4. PIN POSITION TOLERANCE IS ± 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES

GENERIC	
MARKING DIAGRAM*	\Box
XXXXXXXXXXXXXXXXXXXXXXXXXXXX	
ATYYWW	

XXXXX = Specific Device Code G = Pb-Free Package

= Assembly & Test Site Code AT YYWW= Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON20720H	Electronic versions are uncontrolled except when accessed directly from the Document Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	PIM53 93X47 (PRESS FIT)		PAGE 1 OF 1	

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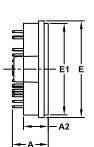
DATE 04 MAY 2020



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MILLIMETERS NOM. MAX. 17.60 Α 16.80 17.20 A2 11.70 12.00 12.30 А3 4.40 4.70 5.00 Α4 16.40 16.70 17.00 0.95 1.00 1.05 b D 92.90 93.00 93.10 D1 104.45 104.75 105.05 D2 81.80 82.00 82.20 107.50 D3 106.90 107.20 Е 46.70 47.00 47.30 E1 44.10 44.40 44.70 E2 38.80 39.00 39.20 Р 5.40 5.50 5.60 Р1 10.60 10.70 10.80 P2 1.80 2.00 2.20

END VIEW

	PIN POSITION		Г		PIN POSITION	
PIN	х	Y		PIN	х	Υ
1	70.50	2.60	1	29	50.70	36.50
2	70.50	0.00		30	50.70	33.50
3	64.25	0.00		31	54.00	36.50
4	61.65	0.00		32	56.60	36.50
5	40.35	0.00		33	67.90	36.50
6	37.75	0.00		34	70.50	36.50
7	31.50	0.00		36	70.50	22.35
8	28.90	0.00		37	70.50	19.75
9	8.85	0.00		38	50.95	19.15
10	6.25	0.00		39	56.85	17.05
11	0.00	0.00		41	53.85	16.55
12	0.00	2.60		42	61.00	6.70
13	0.00	6.75	1	43	58.40	5.35
14	0.00	9.75		44	32.65	27.80
15	0.00	12.75	1	45	33.35	25.20
17	0.00	33.50		47	26.35	18.65
18	0.00	36.50		48	25.35	15.65
19	3.30	36.50		50	39.00	16.55
20	5.90	36.50		51	44.90	19.15
21	19.80	36.50	1	52	42.00	16.55
22	19.80	33.90		53	34.70	10.55
23	25.35	36.50		54	34.70	7.95
24	25.35	33.90		55	12.60	27.65
25	39.25	36.50		56	11.60	25.05
26	41.85	36.50		58	10.85	10.30
27	45.15	36.50		59	10.85	7.70
28	45.15	33.50	1			

'	TOP VIEW	
PACKAGE MARKII LOCATION	D1	— A 3
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SIDE VIEW

	3,52 1,211
-	93.00
	82.00
39.00 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	- 047 048 0551 00 38 37 0 1 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0
00.0	5.25 RECOMMENDED MOUNTING PATTERN dditional Information on our Pb-Free

strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS 5 AND 51 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
- 4. PIN POSITION TOLERANCE IS ± 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Pb-Free Package G

= Assembly & Test Site Code ΑT YYWW= Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	PIM53 93X47 (SOLDER PIN)		PAGE 1 OF 1	

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